

<b>Notice of References Cited</b>	Application/Control No. 10/600,039		Applicant(s)/Patent Under Reexamination CHYAN ET AL.	
	Examiner DUNG A LE		Art Unit 2818	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,713,373 B1	03-2004	Omstead, Thomas R.	438/608
*	B	US-6,664,186 B1	12-2003	Callegari et al.	438/681
*	C	US-6,831,033 B1	12-2004	Yang et al.	502/118
*	D	US-2003/0216036 A1	11-2003	Ma, Shawming	438/637
*	E	US-2004/0241321 A1	12-2004	Ganguli et al.	427/255.28
*	F	US-6,790,773	09-2004	Drewery et al.	438/643
*	G	US-5,618,746	04-1997	Hwang, Cheol-seong	438/3
*	H	US-5,637,533	06-1997	Choi, Kyeong K.	438/643
*	I	US-6,057,232	05-2000	Lee, Chang-Jae	438/658
*	J	US-6,319,832	11-2001	Uhlenbrock et al.	438/681
*	K	US-6,624,513	09-2003	Iwasaki et al.	257/753
*	L	US-6,831,003	12-2004	Huang et al.	438/627
*	M	US-2004/0238965	12-2004	Iwasaki et al.	257/762

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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